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EM-ISight-4 Electromagnetic Scanning System Single Probe Solution 10kHz – 6GHz

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EM-ISight is the first fully flexible EMI/EMC measurement system built on 5 or 6 axis articulated robots designed to support multiple applications and industries including networking, automotive, integrated circuits, aviation, military, and consumer products. Used as a compliance system for IEC-61967-1-6 or a pre-compliance / development tool, the abundance of features meet most requirements for research, design and analytical needs. Custom applications can be developed by the user for EM-ISight allowing for a complete customized test platform. The footprint of the system means that it can be introduced to most measurement environments with multiple frequency range and robot sizes to choose from. The system can be housed in the optional mobile shield, and has an assessed noise floor (sensitivity) of below -139 dBm* when used with high end spectrum analyzers.

EM-ISight is an affordable and easy to use system with great return on investment when using the Far Field Approximation (FFA) module. It is a true alternative to costly pre-compliance EMC chambers which have

high maintenance costs and use significant floor space. Integration of high end Low Noise Amplifiers at the core of the transmission line yield low insertion loss and high unwanted field rejection of better than 25dBm. Easy setup for measurement profiles (less than 60 seconds) using the optional camera and touch detection allow complex topologies of a PCB to be taught in real time.

Integration of 6 axis robots allows for measurements in traditional Cartesian or advanced Horizontal plains. Users can utilize a measurement frequency span of 10 kHz to 6 GHz using our proprietary single probe solution.

Applicable Standards

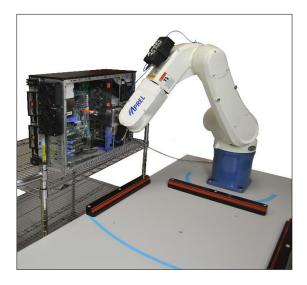
IEC-61967-1-6 VCCI/CISPR 22/FCC Pt 15/22 EN55022 CISPR 12/FCC Pt 18/EN55011/ EN60555/VDE0871 EN55024/EN6100-6-4/GR-1089-CORE ITU-T/ETS300/ IEC-6100-3

Supported Spectrum Analyzers

Tektronix Keysight/Agilent Anritsu Rhode and Schwartz *@1600MHz

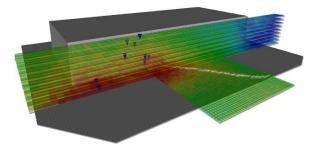
Applications

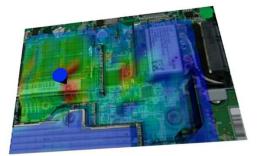
Integrated Circuit/Printed Circuit Board Wireless modules De-Sense testing (receiver circuits) Medical devices Automotive and aviation Electronic device emissions Pre-Compliance testing (emissions/susceptibility) Quality control/audit Consumer products cell phone/computer devices Susceptibility / ESD



NOTE: Signal generator, spectrum analyzer is customer supplied.

Some applications require additional upgrades from a standard package spectrum analyzer; please confirm spectrum analyzer compatibility with APREL.





FFA Tiled Volumes with Hotspot Markers

4D Plot with Interpolated Grid and 3D Hotspot Marker

System Highlights

- Single probe solution from 10kHz to 6GHz
- X/Y/Z scan areas of 300/600/1,000 mm dependent on system
- High resolution scan (>0.02mm)
- Coarse scan with dynamic peak search function
- Real-time topology analysis using dynamic touch detection
- Z height distance from 0.05mm up to 300/600/1,000mm dependent on system
- 4D Measurements of DUT by integrating X/Y/Z & Phi
- Field distribution presented in 2D, 3D or 4D plotting with quick snap image processing @ 2.2µm
- Source direction plots (vector)
- Customizable reports based on user requirements automatically exported to MS Word
- Delta plot measurement function (compare before/after measurements)
- Frequency distribution plots based on span and trace with added limit lines
- AVI export function for real-time visualization of field and frequency distribution
- Advanced measurement functions, single point analysis, quick check, free move and point delta
- Micro Strip Line 10kHz to 6GHz
- Quick scan setup using Optional robot mounted vision camera with 2.2µm pixel size and auto zoom

Standard System Configuration

- Single probe solution for measurements from 10kHz to 6GHz
- Low Noise Amplifier 10kHz 6GHz
- Calibrated H-Field antenna probe to ISO/IEC-17025 standards to IEC-61967-1-6
- Software platform with 1 year fully comprehensive support and feature updates
- Software supports user defined parametric settings, user defined pass/fail graphing, and graphical
 measurement data for statistical readout full 3/4D graphic package for visualization and manipulation of
 measured fields, storage and retrieval of measurement results
- Automated precision antenna probe movement using DENSO robotics
- Remote access to measurement database
- Dynamic process control
- Z-Axis surface detection system
- Collision detection system
- Device Positioning fixture

Optional Accessories/Software

Measurement software and probe upgrade to 20/ 40GHz Mobile Shield for isolation of ambient sources (-145dBm >700MHz) E-Field Antenna Probe Dual Stage Low Noise Amplifiers DC to 6 GHz FFA Far Field Approximation Software USA Ubiquitous Server Application Robot mounted vision camera with 2.2µm pixel size and auto zoom ESD/Susceptibility Test Suite (available winter 2015)



Custom mobile shields available for purchase with EM-ISight Systems

Description	Perform EM Near-field scanning on a PCB, IC, LCD, RFID tag, wireless module, or antenna's for quality control and design optimization, pre-test and certification	
Software	Windows XP, Vista, 7, 8 ar	
		ws for easy setup and data retrieval
	Automatic antenna probe movement control	
	Automatic system control or user definable parametric setup incorporating optional vision camera	
	Visual display including storage and retrieval of measured results in full 3/4D	
	Data tracking for project improvement/quality control	
	Importation of previous measurement profiles to track design/quality improvements	
Applications	Perform EM Test - measure PCB and IC	ments of (near-field) magnetic fields emitted by a DUT, including RF circui
	EM field values measured u	ising an optional spectrum analyzer and presented in 2D/3D/4D form via F
	Typical applications include	,
	EMI noise emission analysis	
	Shielding placement/optimization	
	PCB board or IC design optimization/placement	
	Antenna design optimization	
		nitted radiation analysis of mobile handset LCD or LCD controllers tibility and ESD test modules
Typical Probe Measuring Unit	Antenna:	E or H-field with 0.03mm spatial resolution
, , , , , , , , , , , , , , , , , , ,	Typical frequency range:	Frequency sweep, in band discreet value from 10KHz to 40GHz
	Sensitivity:	Probe Dependent
	VSWR:	<1:2
	Input impedance:	50Ω
	Linearity:	<0.1dB
	LNA (standard):	30dB Preamplifier for EM Measurements from 100kHz to 6GHz
	LNA (Optional)	Up to 20 GHz or 40 GHz
	Noise floor:	Measured with micro strip line (-30dBm @ 10kHz
		-139dB with preamplifier module @ 1600MHz)
	Measurement Uc:	0.05dBm @ 0.05mm Z and 0.1dBm @ 0.2mm X & Y
	Optional probes:	Rosenberger Micro-Coax rectangular and small loop and interface
Measuring Reach and Movement	NO. of axes: 5/6 (X, Y, Z	and θ)
	Typical reach*:	
	Along X & Y axes:	400 x 400mm / 800 x 800 mm / 1000 x 1000 mm / 1100 x 1100 mr
	Along Z axis:	300mm / 700mm / 1140mm
	Rotation θ axis:	360°
	Resolution:	
	X and Y axes:	0.02mm
	Z axis:	0.02mm
	θ axis:	0.1°
	Alignment accuracy:	0.02
	X and Y axes:	0.02mm
	Z axis: 0 axis:	0.02mm ± 1°
		enberger Micro-Coax probes
DUT Orientation		Horizontal
DUT Orientation	Typical:	
		Vertical Custom
Contains Constant		
System Control		rol: IBM PC compatible machine, Intel i3 or better and 512 RAM
	Operating system: Motor controller:	Windows XP/Vista/Win 7/8 Denso
0	Measuring interface:	GPIB/LAN/Serial port
General	Operating requirement:	0° C to $\pm 60^{\circ}$ C
	Temperature:	0° C to +60°C
	humidity:	60% or less Single phase 1001/ 2201/ 50Hz/60Hz*
	AC power input:	Single phase 100V ~ 230V, 50Hz/60Hz*
	Power consumption: Weight:	less than 15A @ 100V 25kg
	Dimension:	80cmx50cmx70cm
Additional Eastures SW		
Additional Features SW	Multiple plots recorded in a	
	Multiple layers on single measurement process	
	Automated peak search Dynamic touch detection and vision control	
	User defined plotting for multiple scan locations	
	Limit exceed search function & User defined limit function	
	Optional Far Field Approximation for EMC test equivalent sites of 3M and 10M	
	Ubiquitous Server Application for custom development of test applications	
	Automated data summary reporting	
	AVI plotting over device or in 3/4D mode	
	Remote access for databas	se data retrieval and batch scanning process
		Anritsu, Agilent/Keysight, Rhode & Schwarz Spectrum Analyzers